



# Document details

< Back to results | 1 of 1

📄 Export 📄 Download 🖨️ Print ✉️ E-mail 📄 Save to PDF ☆ Add to List More... >  
View at Publisher

Microwave and Optical Technology Letters  
Volume 63, Issue 3, March 2021, Pages 970-974

## Optimizing the efficiency of gallium nitride-based light-emitting diodes from contact area of current spreading to electrode (Article) (Open Access)

Shaari, A.<sup>a</sup>, Ahmad Fajri, F.A.<sup>a</sup>, Ahmad Noorden, A.F.<sup>a</sup>, Abdul Kadir, M.Z.<sup>a</sup>, Daud, S.<sup>b</sup>

<sup>a</sup>Advanced Optoelectronics Research (CAPTOR), Department of Physics, Kulliyah of Science, International Islamic University Malaysia, Kuantan, Pahang, Malaysia

<sup>b</sup>Laser Center, Ibnu-Sina Institute for Scientific and Industrial Research (ISI-SIR), Universiti Teknologi Malaysia, Johor Bahru, Johor, Malaysia

### Abstract

View references (19)

A nonuniform current spreading in the current spreader layer greatly reduced the internal quantum efficiency (IQE) of the light-emitting diodes (LED). The effects of the current spreading layer on the electrode contact area toward the IQE in a vertical design of gallium nitride (GaN)-based LED chip is analytically analyzed. The contact area was varied by changing the value of the electrode's width from 2 to 12 μm. Efficiency droop and current density at peak IQE are analyzed based on contact area. The width of 2 μm requires 1.6 μAm<sup>-2</sup> current density to achieve peak efficiency and produces a droop of 0.2150. The width of 12 μm requires 9.6 μAm<sup>-2</sup> current density to achieve peak efficiency and produces 0.0557 droop. The increase in contact area increases the current density needed to achieve peak IQE while decreases efficiency droop. The optimal spreader contact width of this vertical LED design is 6 μm. © 2020 Wiley Periodicals LLC

### SciVal Topic Prominence ⓘ

Topic: Flip Chip | Ingan | Light Emitting Diodes

Prominence percentile: 88.704 ⓘ

### Author keywords

current density current spreader efficiency droop internal quantum efficiency light-emitting diode

### Indexed keywords

Engineering controlled terms: Current density Efficiency Electrodes Gallium nitride III-V semiconductors Nitrides Spreaders

Engineering uncontrolled terms: Current spreading Efficiency droops Electrode contacts Gallium nitrides (GaN) Internal quantum efficiency Nitride based light emitting diodes Nonuniform current Peak efficiency

Engineering main heading: Light emitting diodes

### Funding details

Funding sponsor	Funding number	Acronym
	FRGS 19-033-0641,FRGS/1/2018/TK07/UIAM/02/1	

Metrics ⓘ View all metrics >



PlumX Metrics Usage, Captures, Mentions, Social Media and Citations beyond Scopus.

Cited by 0 documents

Inform me when this document is cited in Scopus:

Set citation alert >

### Related documents

Effect of carbon nanotube pattern on the laser lift off and quantum efficiencies of near UV vertical LEDs

Tian, M.F., Huang, L.H., Mei, Y. (2021) *Journal of Luminescence*

Impact of grain growth of silver reflective electrode by electron bombardment on external quantum efficiency of III-nitride micro-light-emitting diode arrays

Hong, I.Y., Islam, A.B.M.H., Kim, T.K. (2020) *Applied Surface Science*

The role of ITO resistivity on current spreading and leakage in InGaN/GaN light emitting diodes  
Sheremet, V., Genç, M., Elçi, M. (2017) *Superlattices and Microstructures*

View all related documents based on references

Find more related documents in Scopus based on:

Authors > Keywords >

Funding sponsor	Funding number	Acronym
Kementerian Pendidikan Malaysia		KPM

#### Funding text #1

This work was supported by the Ministry of Education (Malaysia) through Fundamental Research Grant Scheme (Project No.: FRGS 19-033-0641) (Ministry Project Id: FRGS/1/2018/TK07/UIAM/02/1). This manuscript has not been published and is not under consideration for publication elsewhere.

#### Funding text #2

This work was supported by the Ministry of Education (Malaysia) through Fundamental Research Grant Scheme (Project No.: FRGS 19-033-0641) (Ministry Project Id: FRGS/1/2018/TK07/UIAM/02/1). This manuscript has not been published and is not under consideration for publication elsewhere.

ISSN: 08952477  
 CODEN: MOTLE  
 Source Type: Journal  
 Original language: English

DOI: 10.1002/mop.32698  
 Document Type: Article  
 Publisher: John Wiley and Sons Inc

#### References (19)

[View in search results format >](#)

All [Export](#) [Print](#) [E-mail](#) [Save to PDF](#) [Create bibliography](#)

- 1 Khan, T., Bodrogi, P., Vinh, Q.T., Winkler, H. (2015) *LED Lighting: Technology and Perception*. Cited 22 times. Weinheim, Germany, John Wiley & Sons
- 
- 2 Krames, M.R., Shchekin, O.B., Mueller-Mach, R., Mueller, G.O., Zhou, L., Harbers, G., Craford, M.G. Status and future of high-power light-emitting diodes for solid-state lighting ([Open Access](#)) (2007) *IEEE/OSA Journal of Display Technology*, 3 (2), pp. 160-175. Cited 1617 times. doi: 10.1109/JDT.2007.895339 [View at Publisher](#)
- 
- 3 Tsao, J.Y., Coltrin, M.E., Crawford, M.H., Simmons, J.A. Solid-state lighting: An integrated human factors, technology, and economic perspective (2010) *Proceedings of the IEEE*, 98 (7), art. no. 5456162, pp. 1162-1179. Cited 117 times. <http://ieeexplore.ieee.org/ezproxy.um.edu.my/xpl/RecentIssue.jsp?punumber=5> doi: 10.1109/JPROC.2009.2031669 [View at Publisher](#)
- 
- 4 Huang, S., Fan, B., Chen, Z., Zheng, Z., Luo, H., Wu, Z., Wang, G., (...), Jiang, H. Lateral current spreading effect on the efficiency droop in GaN based light-emitting diodes (2013) *IEEE/OSA Journal of Display Technology*, 9 (4), art. no. 6418054, pp. 266-271. Cited 21 times. doi: 10.1109/JDT.2012.2225092 [View at Publisher](#)
- 
- 5 Kowalczewski, P., Kuc, M., Piskorski, Ł., Sarzaãa, R.P., Nakwaski, W. Simulation of an operation of zinc oxide light-emitting diodes (2011) *Microwave and Optical Technology Letters*, 53 (9), pp. 2086-2090. Cited 4 times. doi: 10.1002/mop.26175 [View at Publisher](#)